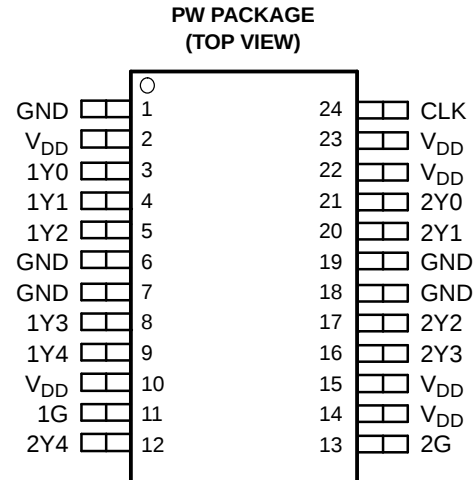


2.5-V TO 3.3-V HIGH-PERFORMANCE CLOCK BUFFER

- **High-Performance 1:10 Clock Driver for General-Purpose Applications**
- **Pin-to-Pin Skew < 100 ps at V_{DD} 3.3 V**
- **V_{DD} Range = 2.3 V to 3.6 V**
- **Input Clock Up To 200 MHz (See Figure 7)**
- **Operating Temperature Range -40°C to 85°C**
- **Output Enable Glitch Suppression**
- **Distributes One Clock Input to Two Banks of Five Outputs**
- **Packaged in 24-Pin TSSOP**
- **Pin-to-Pin Compatible to the CDCVF2310, Except the $R = 22\text{-}\Omega$ Series Damping Resistors at Yn**



DESCRIPTION

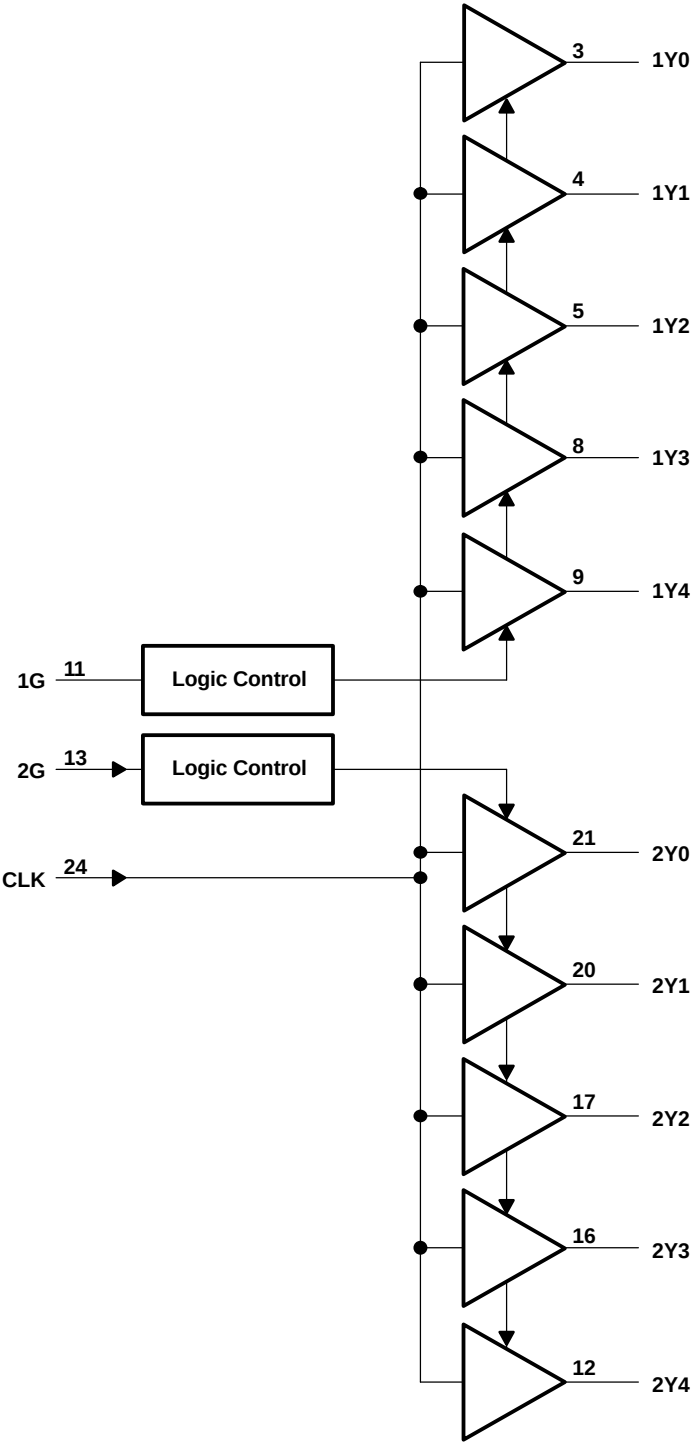
The CDCVF310 is a high-performance, low-skew clock buffer that operates up to 200 MHz. Two banks of five outputs each provide low-skew copies of CLK. After power up, the default state of the outputs is low regardless of the state of the control pins. For normal operation, the outputs of bank 1Y[0:4] or 2Y[0:4] can be placed in a low state when the control pins (1G or 2G, respectively) are held low and a negative clock edge is detected on the CLK input. The outputs of bank 1Y[0:4] or 2Y[0:4] can be switched into the buffer mode when the control pins (1G and 2G) are held high and a negative clock edge is detected on the CLK input. The device operates in a 2.5-V and 3.3-V environment. The built-in output enable glitch suppression ensures a synchronized output enable sequence to distribute full period clock signals.

The CDCVF310 is characterized for operation from -40°C to 85°C .



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

FUNCTIONAL BLOCK DIAGRAM



FUNCTION TABLE

INPUT			OUTPUT	
1G	2G	CLK	1Y[0:4]	2Y[0:4]
L	L	↓	L	L
H	L	↓	CLK ⁽¹⁾	L
L	H	↓	L	CLK ⁽¹⁾
H	H	↓	CLK ⁽¹⁾	CLK ⁽¹⁾

- (1) After detecting one negative edge on the CLK input, the output follows the input CLK if the control pin is held high.

Terminal Functions

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
1G	11	I	Output enable control for 1Y[0:4] outputs. This output enable is active-high, meaning the 1Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.
2G	13	I	Output enable control for 2Y[0:4] outputs. This output enable is active-high, meaning the 2Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.
1Y[0:4]	3, 4, 5, 8, 9	O	Buffered output clocks
2Y[0:4]	21, 20, 17, 16, 12	O	Buffered output clocks
CLK	24	I	Input reference frequency
GND	1, 6, 7, 18, 19		Ground
V _{DD}	2, 10, 14, 15, 22, 23		DC power supply, 2.3 V – 3.6 V

DETAILED DESCRIPTION

Output Enable Glitch Suppression Circuit

The purpose of the glitch suppression circuitry is to ensure the output enable sequence is synchronized with the clock input such that the output buffer is enabled or disabled on the next full period of the input clock (negative edge triggered by the input clock) (see Figure 1).

The G input must fulfill the timing requirements (t_{su} , t_h) according to the *Switching Characteristics* table for predictable operation.

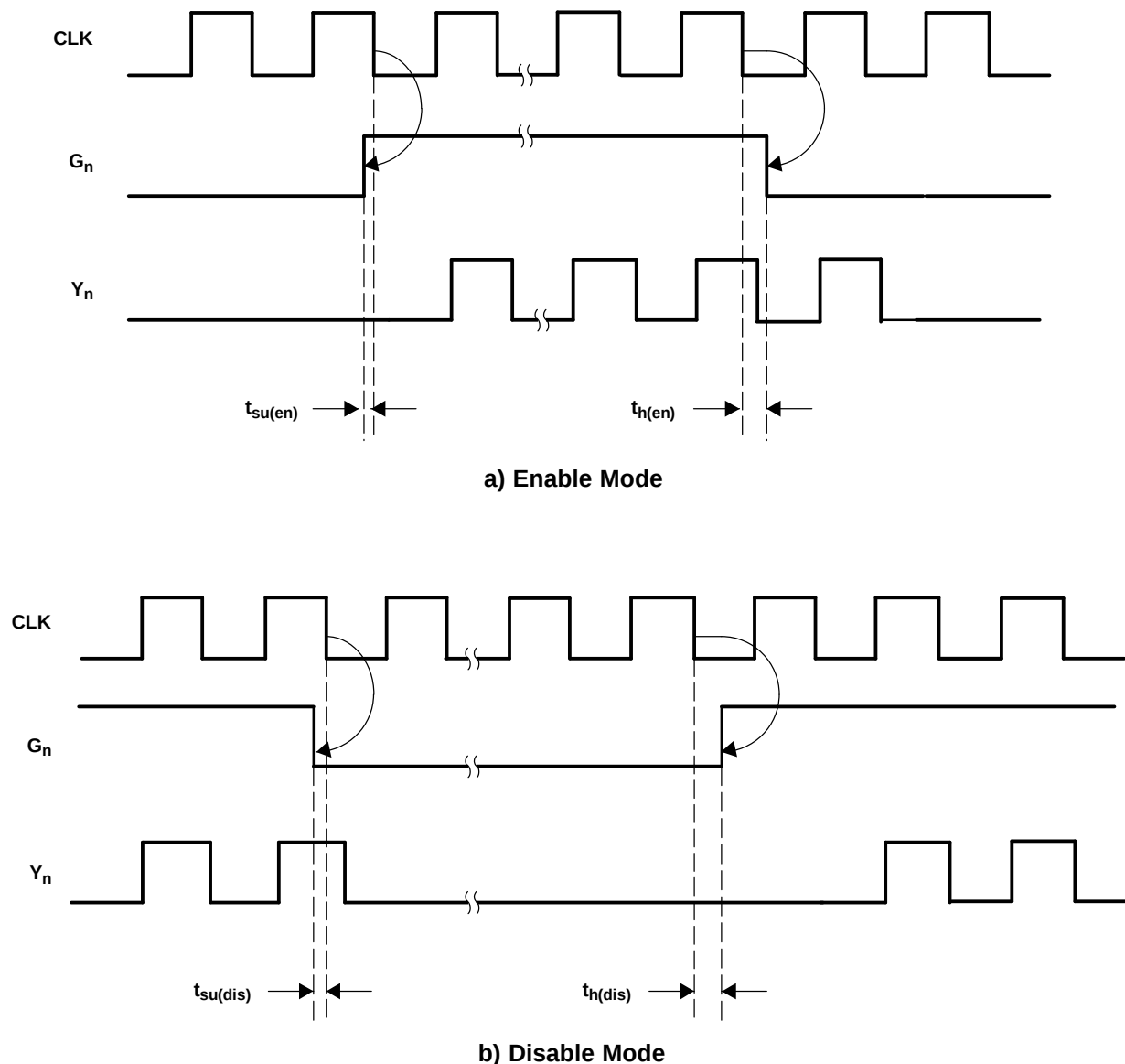


Figure 1. Enable and Disable Mode Relative to CLK↓

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

Supply voltage range, V_{DD}	–0.5 V to 4.6 V
Input voltage range, V_I ⁽²⁾⁽³⁾	–0.5 V to $V_{DD} + 0.5$ V
Output voltage range, V_O ⁽²⁾⁽³⁾	–0.5 V to $V_{DD} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{DD}$)	±50 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{DD}$)	±50 mA
Continuous total output current, I_O ($V_O = 0$ to V_{DD})	±50 mA
Package thermal impedance, θ_{JA} ⁽⁴⁾ : PW package	88°C/W, high K
	120°C/W, low K
Storage temperature range T_{stg}	–65°C to 150°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (3) This value is limited to 4.6 V maximum.
- (4) The package thermal impedance is calculated in accordance with JESD 51.

RECOMMENDED OPERATING CONDITIONS ⁽¹⁾

		MIN	NOM	MAX	UNIT
Supply voltage, V_{DD}		2.3	2.5		V
			3.3	3.6	
Low-level input voltage, V_{IL}	$V_{DD} = 3$ V to 3.6 V			0.8	V
	$V_{DD} = 2.3$ V to 2.7 V			0.7	
High-level input voltage, V_{IH}	$V_{DD} = 3$ V to 3.6 V	2			V
	$V_{DD} = 2.3$ V to 2.7 V	1.7			
Input voltage, V_I		0		V_{DD}	V
High-level output current, I_{OH}	$V_{DD} = 3$ V to 3.6 V			–12	mA
	$V_{DD} = 2.3$ V to 2.7 V			–6	
Low-level output current, I_{OL}	$V_{DD} = 3$ V to 3.6 V			12	mA
	$V_{DD} = 2.3$ V to 2.7 V			6	
Operating free-air temperature, T_A		–40		85	°C

- (1) Unused inputs must be held high or low to prevent them from floating.

TIMING REQUIREMENTS

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{clk}	Clock frequency	$V_{DD} = 2.3$ V to 3.6 V, See Figure 7	0		200	MHz

ELECTRICAL CHARACTERISTICSover recommended operating free-air temperature range (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{IK} Input voltage	V _{DD} = 3 V, I _I = –18 mA			–1.2	V
I _I Input current	V _I = 0 V or V _{DD}			±5	μA
I _{DD} ⁽²⁾ Static device current	CLK = 0 V or V _{DD} = 3.6 V, I _O = 0 mA			80	μA
C _I Input capacitance	V _{DD} = 2.3 V to 3.6 V, V _I = 0 V or V _{DD}		2.5		pF
C _O Output capacitance	V _{DD} = 2.3 V to 3.6 V, V _I = 0 V or V _{DD}		2.6		pF
C _{PD} Power dissipation ⁽³⁾	V _{DD} = 2.3 V to 3.6 V, V _I = 0 V or V _{DD}			32	pF

(1) All typical values are with respect to nominal V_{DD}.(2) For dynamic I_{DD} over Frequency see Figure 6.

(3) This is the formula for the power dissipation calculation.

$$P_{\text{tot}} = P_{\text{stat}} + P_{\text{Dyn}} + P_{\text{Load}}[\text{W}]$$

$$P_{\text{stat}} = V_{\text{DD}} \times I_{\text{DD}} [\text{W}]$$

$$P_{\text{Dyn}} = C_{\text{PD}} \times V_{\text{DD}} \times V_{\text{DD}} \times f [\text{W}]$$

$$P_{\text{Load}} = C_{\text{Load}} \times V_{\text{DD}} \times V_{\text{DD}} \times f \times n [\text{W}]$$

n = Number of switching output pins

V_{DD} = 3.3 V ±0.3 V

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH} High-level output voltage	V _{DD} = min to max, I _{OH} = –100 μA	V _{DD} - 0.2			V
	V _{DD} = 3 V, I _{OH} = –12 mA	2.1			
	I _{OH} = –6 mA	2.4			
V _{OL} Low-level output voltage	V _{DD} = min to max, I _{OL} = 100 μA			0.2	V
	V _{DD} = 3 V, I _{OL} = 12 mA			0.4	
	I _{OL} = 6 mA			0.3	
I _{OH} High-level output current	V _{DD} = 3 V, V _O = 1 V	–37			mA
	V _{DD} = 3.3 V, V _O = 1.65 V		–57		
	V _{DD} = 3.6 V, V _O = 3.135 V			–38	
I _{OL} Low-level output current	V _{DD} = 3 V, V _O = 1.95 V	37			mA
	V _{DD} = 3.3 V, V _O = 1.65 V		57		
	V _{DD} = 3.6 V, V _O = 0.4 V			38	

(1) All typical values are with respect to nominal V_{DD}.**V_{DD} = 2.5 V ±0.2 V**

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH} High-level output voltage	V _{DD} = min to max, I _{OH} = –100 μA	V _{DD} - 0.2			V
	V _{DD} = 2.3 V, I _{OH} = –6 mA	1.8			
V _{OL} Low-level output voltage	V _{DD} = min to max, I _{OL} = 100 μA			0.2	V
	V _{DD} = 2.3 V, I _{OL} = 6 mA			0.4	
I _{OH} High-level output current	V _{DD} = 2.3 V, V _O = 1 V	–20			mA
	V _{DD} = 2.5 V, V _O = 1.25 V		–36		
	V _{DD} = 2.7 V, V _O = 2.375 V			–25	
I _{OL} Low-level output current	V _{DD} = 2.3 V, V _O = 1.2 V	20			mA
	V _{DD} = 2.5 V, V _O = 1.25 V		36		
	V _{DD} = 2.7 V, V _O = 0.3 V			25	

(1) All typical values are with respect to nominal V_{DD}.

SWITCHING CHARACTERISTICS

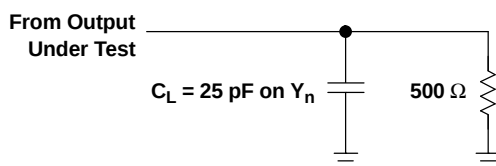
over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V_{DD} = 3.3 V ±0.3 V (see Figure 2)						
t _{PLH}	CLK to Yn	f = 0 MHz to 200 MHz	1		2.8	ns
t _{PHL}			1		2.8	
t _{sk(o)}	Output skew (Ym to Yn) ⁽²⁾ (see Figure 4)			100	150	ps
t _{sk(p)}	Pulse skew (see Figure 5)				250	ps
t _{sk(pp)}	Part-to-part skew				350	ps
t _r	Rise time	V _O = 0.4 V to 2 V	1.3		2.7	V/ns
t _f	Fall time	V _O = 2 V to 0.4 V	1.3		2.7	V/ns
t _{SU(en)}	Enable setup time, G_high before CLK ↓		0.1			ns
t _{SU(dis)}	Disable setup time, G_low before CLK ↓		0.1			ns
t _{H(en)}	Enable hold time, G_high after CLK ↓		0.4			ns
t _{H(dis)}	Disable hold time, G_low after CLK ↓		0.4			ns
V_{DD} = 2.5 V ±0.2 V (see Figure 2)						
t _{PLH}	CLK to Yn	f = 0 MHz to 200 MHz	1.3		4	ns
t _{PHL}			1.3		4	
t _{sk(o)}	Output skew (Ym to Yn) ⁽²⁾ (see Figure 4)			150	230	ps
t _{sk(p)}	Pulse skew (see Figure 5)				280	ps
t _{sk(pp)}	Part-to-part skew				400	ps
t _r	Rise time	V _O = 0.4 V to 1.7 V	0.5		1.6	V/ns
t _f	Fall time	V _O = 1.7 V to 0.4 V	0.5		1.6	V/ns
t _{SU(en)}	Enable setup time, G_high before CLK ↓		0.1			ns
t _{SU(dis)}	Disable setup time, G_low before CLK ↓		0.1			ns
t _{H(en)}	Enable hold time, G_high after CLK ↓		0.4			ns
t _{H(dis)}	Disable hold time, G_low after CLK ↓		0.4			ns

(1) All typical values are with respect to nominal V_{DD}.

(2) The t_{sk(o)} specification is only valid for equal loading of all outputs.

PARAMETER MEASUREMENT INFORMATION



- A. C_L includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: Clock Frequency $\leq 200 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r < 1.2 \text{ ns}$, $t_f < 1.2 \text{ ns}$.

Figure 2. Test Load Circuit

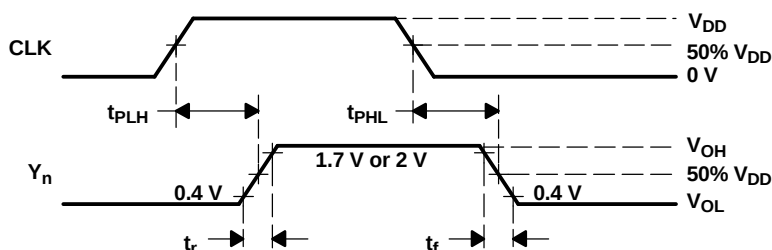


Figure 3. Voltage Waveforms Propagation Delay Times

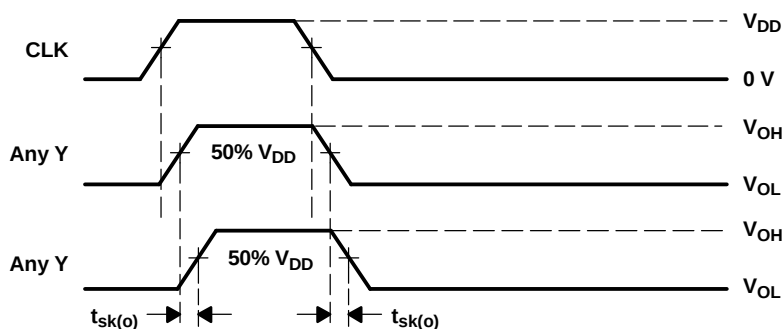
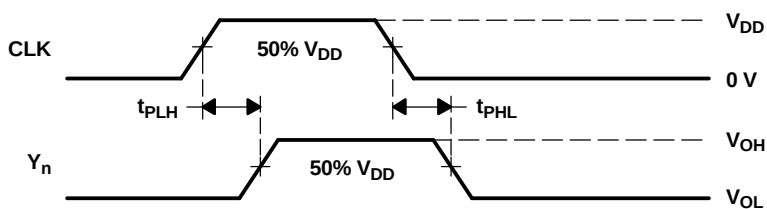


Figure 4. Output Skew



NOTE: $t_{sk(p)} = |t_{PLH} - t_{PHL}|$

Figure 5. Pulse Skew

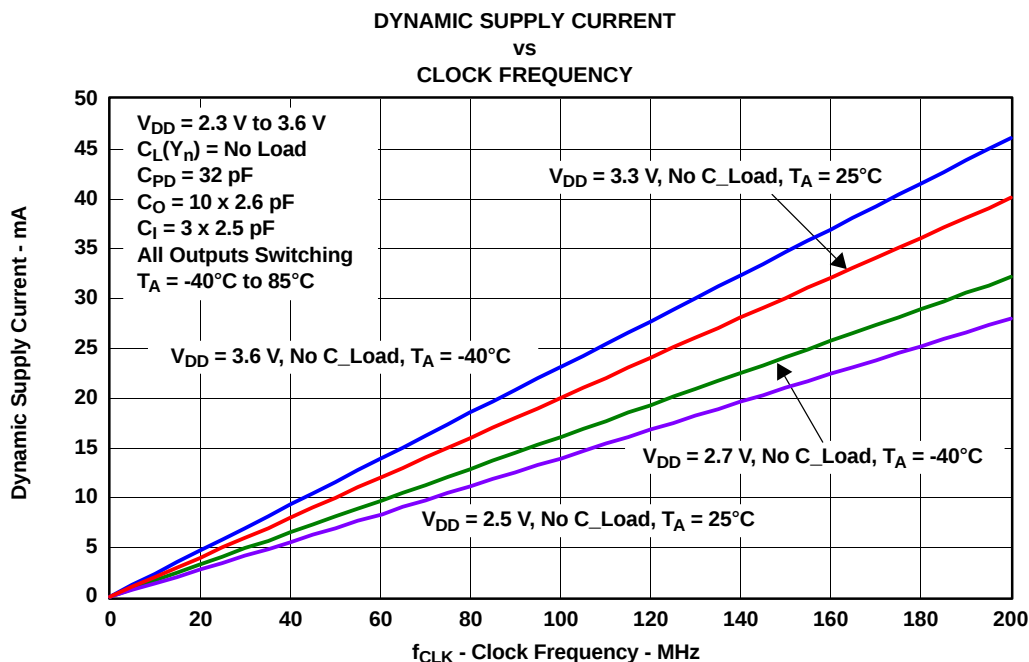


Figure 6.

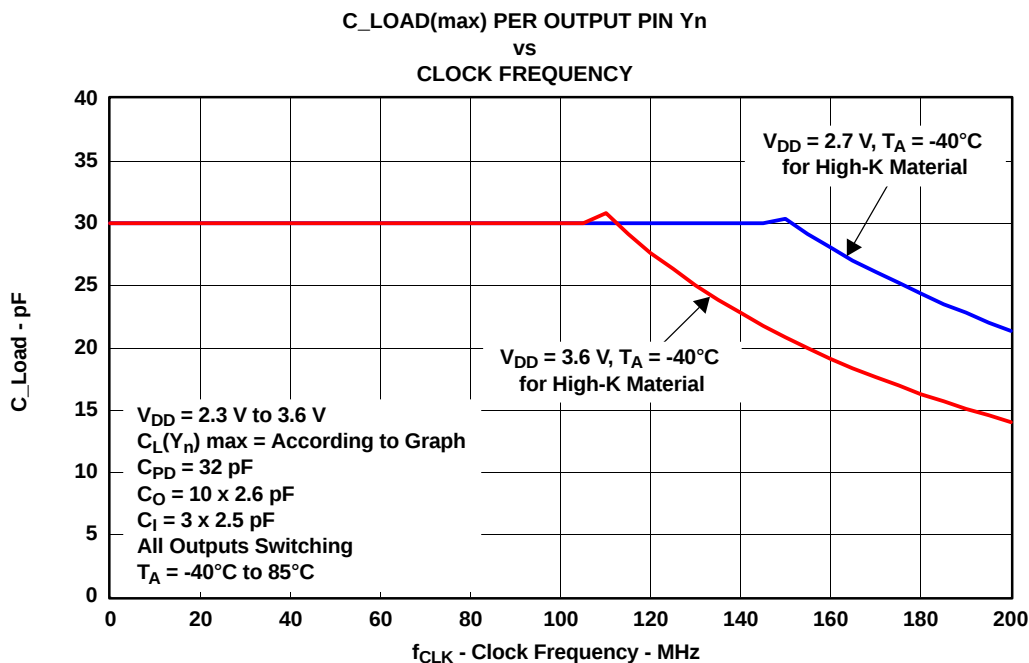


Figure 7.

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CDCVF310PW	ACTIVE	TSSOP	PW	24	60	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CDCVF310PWR	ACTIVE	TSSOP	PW	24	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CDCVF310PWRG4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
 D. Falls within JEDEC MO-153

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Mailing Address: Texas Instruments
Post Office Box 655303 Dallas, Texas 75265

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